SNx4HC393 Dual 4-Bit Binary Counters

1 Features

- Wide operating voltage range of 2V to 6V
- Outputs can drive up to 10 LSTTL loads
- Low power consumption: 80µA max I_{CC}
- Typical t_{pd} = 13ns
- ±4mA output drive at 5V
- Low input current of 1µA max
- Dual 4-bit binary counters with individual clocks
- Direct clear for each 4-bit counter
- Can significantly improve system densities by reducing counter package count by 50%

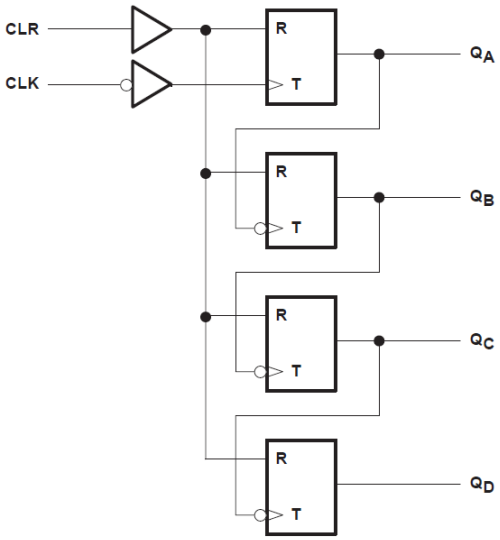
2 Description

The ’HC393 devices contain eight flip-flops and additional gating to implement two individual 4-bit counters in a single package.

Device Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)	BODY SIZE(3)
SNx4HC393	D (SOIC, 14)	8.65 mm x 6mm	8.65 mm x 3.9 mm
	N (PDIP, 14))	19.3mm x 9.4mm	19.3mm x 6.35mm
	NS (SOP, 14)	10.3 mm x 7.8mm	10.3 mm x 5.3 mm
	DB (SSOP, 14)	6.2 mm x 7.8mm	6.2 mm x 5.3 mm
	PW (TSSOP, 14)	5 mm x 6.4mm	5 mm x 4.4 mm
	DYY (SOT-23, 14)	4.2mm x 3.26mm	4.2mm x 2mm
	J (CDIP, 14)	19.55mm x 7.9mm	19.55 mm x 6.7mm
	W (CFP, 14)	9.21mm x 9 mm	9.21mm x 6.28mm
	FK (LCCC, 14)	8.9mm x 8.9mm	8.9mm x 8.9mm

(1) For more information, see Mechanical, Packaging, and Orderable Information.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.
(3) The body size (length × width) is a nominal value and does not include pins.



Logic Diagram, Each Counter (Positive Logic)

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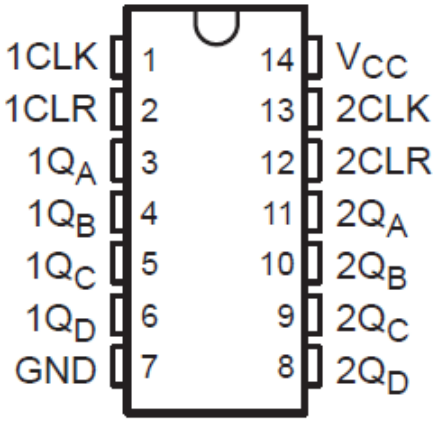
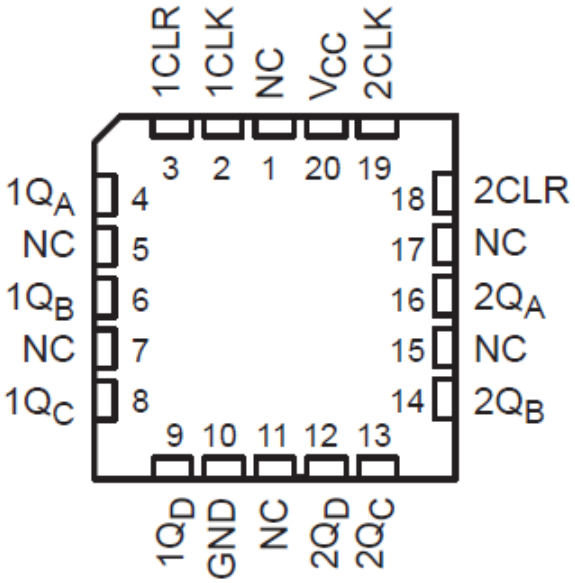
3 Pin Configuration and Functions



SN54HC393 J or W Package, 14-Pin CDIP or CFP; SN74HC393 D, DB, DYY, N, NS, or PW Package; 14-Pin SOIC, SSOP, SOT-23, TVSOP, SOP, or TSSOP (Top View)



A. NC - No internal connection

SN54HC393 FK Package, 20-Pin LCCC (Top View)

Table 3-1. Pin Functions

PIN		TYPE[1]	DESCRIPTION
NAME	NO.		
1CLK	1	I	Counter 1 Clock Input
1CLR	2	I	Counter 1 Clear Input
$1Q_A$	3	O	Counter 1 A Output
$1Q_B$	4	O	Counter 1 B Output
$1Q_C$	5	O	Counter 1 B Output
$1Q_D$	6	O	Counter 1 B Output
GND	7	G	Ground
$2Q_D$	8	O	Counter 2 D Output
$2Q_C$	9	O	Counter 2 C Output
$2Q_B$	10	O	Counter 2 B Output
$2Q_A$	11	O	Counter 2 A Output
2CLR	12	I	Counter 2 Clear Input
2CLK	13	I	Counter 2 Clock Input
V_{CC}	14	P	V_{CC}

1. I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

4 Specifications

4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	7	V
I_{IK}	Input clamp current(2)	For $V_I < 0$ V or $V_I > V_{CC}$		±20	mA
I_{OK}	Output clamp current(2)	For $V_O < 0$ V or $V_O > V_{CC}$		±20	mA
I_O	Continuous output current	V_O = 0 to V_{CC}		±25	mA
	Continuous current through V_{CC} or GND			±50	mA
T_{stg}	Storage temperature range		-65	150	℃

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

4.2 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			SN54HC393			SN74HC393			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		2	5	6	2	5	6	V
V_{IH}	High-level input voltage	V_{CC} = 2 V	1.5			1.5			V
		V_{CC} = 4.5 V	3.15			3.15			
		V_{CC} = 6 V	4.2			4.2			
V_{IL}	Low-level input voltage	V_{CC} = 2 V			0.5			0.5	V
		V_{CC} = 4.5 V			1.35			1.35	
		V_{CC} = 6 V			1.8			1.8	
V_I	Input voltage		0		V_{CC}	0		V_{CC}	V
V_O	Output voltage		0		V_{CC}	0		V_{CC}	V
$\Delta t/\Delta v$(2)	Input transition rise/fall time	V_{CC} = 2 V			1000			1000	ns
		V_{CC} = 4.5 V			500			500	
		V_{CC} = 6 V			400			400	
T_A	Operating free-air temperature		-55		125	-40		85	℃

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.
(2) If this device is used in the threshold region (from V_{ILmax} = 0.5 V to V_{IHmin} = 1.5 V), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at t_t = 1000 ns and V_{CC} = 2 V does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.

4.3 Thermal Information

THERMAL METRIC(1)		SN74HC393						UNIT
		D (SOIC)	DB (SSOP)	DYY (SOT-23)	N (PDIP)	NS (SO)	PW (TSSOP)	
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	86	96	124.1	80	76	113	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

4.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V_{CC}	T_A = 25°C			SN54HC393		SN74HC393		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V_{OH}	V_I = V_{IH} or V_{IL}	I_{OH} = -20 µA	2 V	1.9	1.998		1.9		1.9		V
			4.5 V	4.4	4.499		4.4		4.4		
			6 V	5.9	5.999		5.9		5.9		
		I_{OH} = -4 mA	4.5 V	3.98	4.3		3.7		3.84		
		I_{OH} = -5.2 mA	6 V	5.48	5.8		5.2		5.34		
V_{OL}	V_I = V_{IH} or V_{IL}	I_{OL} = 20 µA	2 V		0.002	0.1		0.1		0.1	V
			4.5 V		0.001	0.1		0.1		0.1	
			6		0.001	0.1		0.1		0.1	
		I_{OL} = 4 mA	4.5 V		0.17	0.26		0.4		0.33	
		I_{OL} = 5.2 mA	6 V		0.15	0.26		0.4		0.33	
I_I	V_I = V_{CC} or 0		6 V		±0.1	±100		±1000		±1000	nA
I_{CC}	V_I = V_{CC} or 0	I_O = 0	6 V			8		160		80	µA
C_i			2 V to 6 V		3	10		10		10	pF

4.5 Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			V_{CC}	T_A = 25°C		SN54HC393		SN74HC393		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
f_{clock}	Clock frequency		2 V		6		4.2		5	MHz
			4.5 V		31		21		25	
			6 V		36		25		28	
t_w	Pulse duration	CLK high or low	2 V	80		120		100		ns
			4.5 V	16		24		20		
			6 V	14		20		18		
		CLR high	2 V	80		120		100		
			4.5 V	16		24		20		
			6 V	14		20		18		
t_{su}	Setup time, CLR inactive		2 V	25		25		25		ns
			4.5 V	5		5		5		
			6 V	5		5		5		

4.6 Switching Characteristics

over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (Figure 5-1)

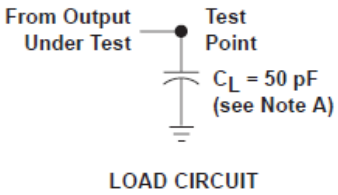
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC}	T_A = 25°C			SN54HC393		SN74HC393		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f_{max}	CLK	Q_A	2 V	6	10		4.2		5		MHz
			4.5 V	31	50		21		25		
			6 V	36	60		25		28		
t_{pd}	CLK	Q_A	2 V		50	120		180		150	ns
			4.5 V		15	24		36		30	
			6 V		13	20		31		26	
		Q_B	2 V		72	190		285		240	
			4.5 V		22	38		57		47	
			6 V		18	32		48		40	
		Q_C	2 V		91	240		360		300	
			4.5 V		28	48		72		60	
			6 V		22	41		61		51	
		Q_D	2 V		100	290		430		360	
			4.5 V		32	58		87		72	
			6 V		24	50		74		62	
t_{PHL}	CLR	Any	2 V		45	165		250		205	
			4.5 V		17	33		49		41	
			6 V		14	28		42		35	
t_t		Any	2 V		28	75		110		95	ns
			4.5 V		8	15		22		19	
			6 V		6	13		19		16	

4.7 Operating Characteristics

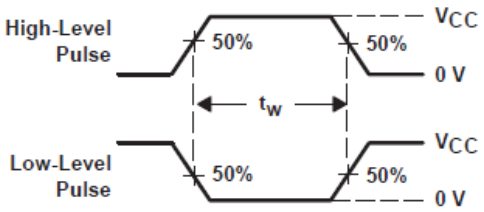
T_A = 25°C

PARAMETER		TEST CONDITIONS	TYP	UNIT
C_{PD}	Power dissipation capacitance	No load	40	pF

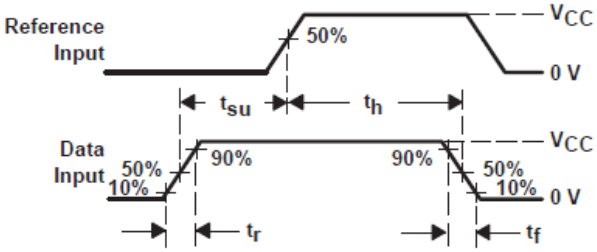
5 Parameter Measurement Information



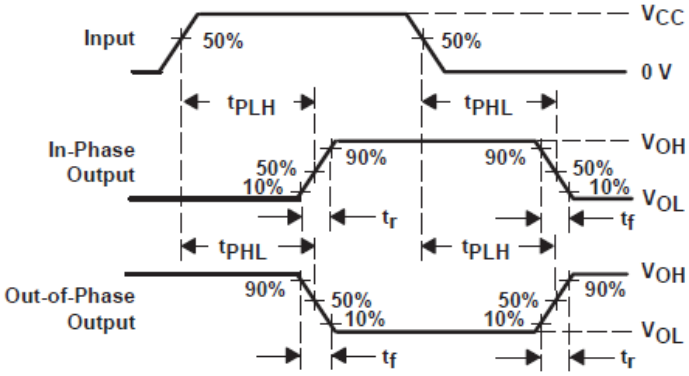
LOAD CIRCUIT



VOLTAGE WAVEFORMS
PULSE DURATIONS



VOLTAGE WAVEFORMS
SETUP AND HOLD AND INPUT RISE AND FALL TIMES



VOLTAGE WAVEFORMS
PROPAGATION DELAY AND OUTPUT TRANSITION TIMES

A. C_L includes probe and test-fixture capacitance.
B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, Z_O = 50 Ω, t_r = 6 ns, t_f = 6 ns.
C. For clock inputs, f_{max} is measured when the input duty cycle is 50%.
D. The outputs are measured one at a time with one input transition per measurement.
E. t_{PLH} and t_{PHL} are the same as t_{pd}.

Figure 5-1. Load Circuit and Voltage Waveforms

6 Detailed Description

6.1 Overview

The ’HC393 devices contain eight flip-flops and additional gating to implement two individual 4-bit counters in a single package. These devices comprise two independent 4-bit binary counters, each having a clear (CLR) and a clock (CLK) input. N-bit binary counters can be implemented with each package, providing the capability of divide by 256. The ’HC393 devices have parallel outputs from each counter stage so that any submultiple of the input count frequency is available for system timing signals.

6.2 Functional Block Diagram

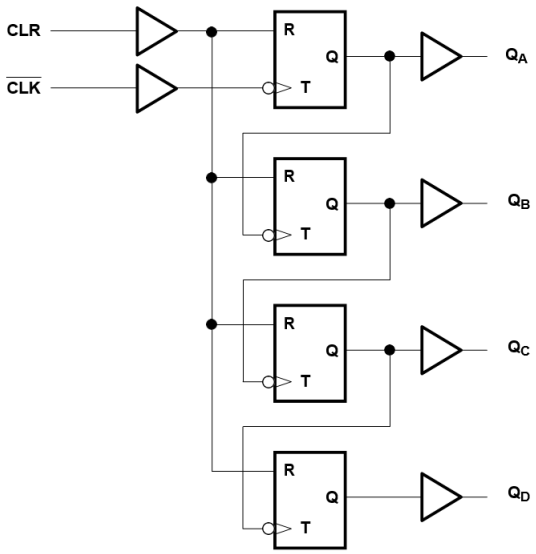


Figure 6-1. Logic Diagram, Each Counter (Positive Logic)

6.3 Device Functional Modes

Table 6-1. Function Table Count Sequence (Each Buffer)

COUNT	OUTPUTS			
	Q_D	Q_C	Q_B	Q_A
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H
10	H	L	H	L
11	H	L	H	H
12	H	H	L	L
13	H	H	L	H
14	H	H	H	L
15	H	H	H	H

7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1µF capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1µF and 1µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

7.2 Layout

7.2.1 Layout Guidelines

- Bypass capacitor placement
  - Place near the positive supply terminal of the device
  - Provide an electrically short ground return path
  - Use wide traces to minimize impedance
  - Keep the device, capacitors, and traces on the same side of the board whenever possible
- Signal trace geometry
  - 8mil to 12mil trace width
  - Lengths less than 12cm to minimize transmission line effects
  - Avoid 90° corners for signal traces
  - Use an unbroken ground plane below signal traces
  - Flood fill areas around signal traces with ground
  - For traces longer than 12cm
    - Use impedance controlled traces
    - Source-terminate using a series damping resistor near the output
    - Avoid branches; buffer signals that must branch separately

7.2.2 Layout Example

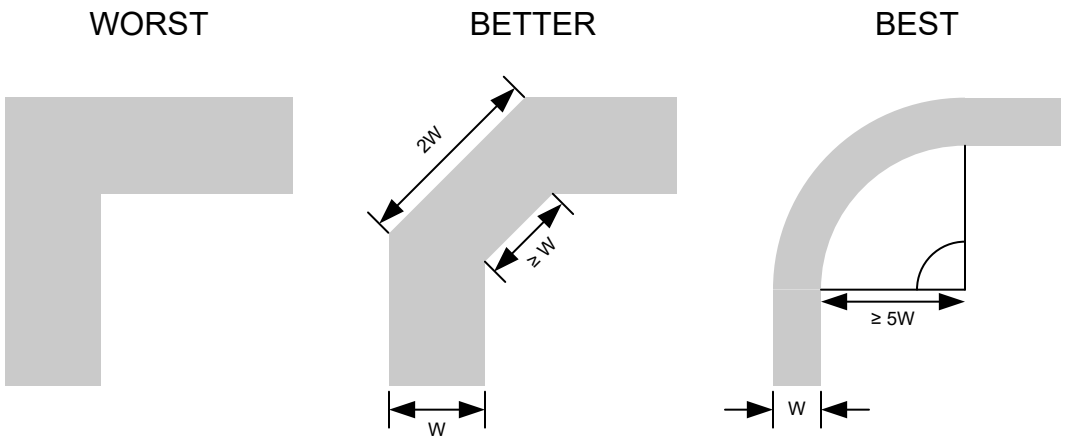


Figure 7-1. Example Trace Corners for Improved Signal Integrity

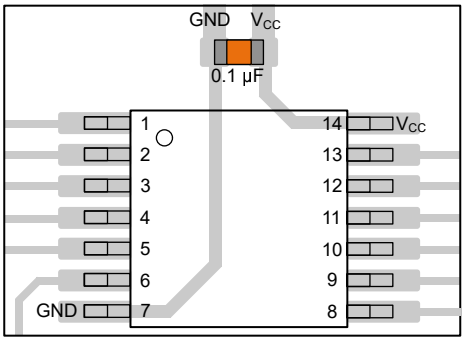


Figure 7-2. Example Bypass Capacitor Placement for TSSOP and Similar Packages

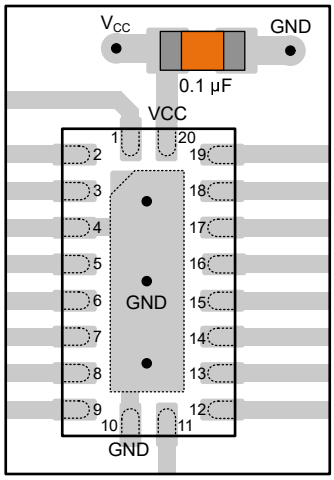


Figure 7-3. Example Bypass Capacitor Placement for WQFN and Similar Packages

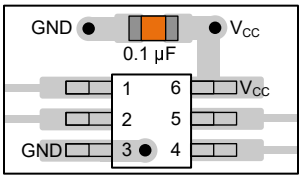


Figure 7-4. Example Bypass Capacitor Placement for SOT, SC70 and Similar Packages

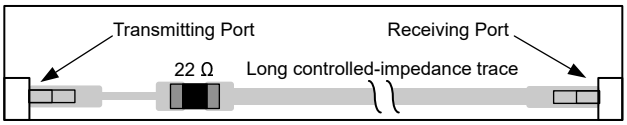


Figure 7-5. Example Damping Resistor Placement for Improved Signal Integrity

8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 Documentation Support

8.1.1 Related Documentation

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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8.4 Trademarks

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8.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (July 2003) to Revision E (December 2024)	Page
• Added *Device Information* table, *Pin Functions* table, *Thermal Information* table, *Device Functional Modes,*Application and Implementation section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section	1
• Added DYY package to *Device Information* table, *Pin Functions and Configuration* section, and *Thermal Information* table	1

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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